

Notice of References Cited	Application/Control No. 10/783,195	Applicant(s)/Patent Under Reexamination LIN ET AL.	
	Examiner Thao X. Le	Art Unit 2814	Page 1 of 1

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*	A	US-2003/0102551	06-2003	Kikuchi, Hidekazu	257/701
*	B	US-6,605,549	08-2003	Leu et al.	438/758
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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